

<b>LIST OF REFERENCES CITED BY APPLICANT</b> (Use several sheets if necessary)		<b>ATTY. DOCKET NO.</b>	<b>APPLICATION NO.</b>
		11543-006-999	10/568,264
		<b>APPLICANT</b>	
		Liew et al.	
<b>NATIONAL STAGE</b>	<b>ART UNIT</b>		
FILING DATE	1631		
February 13, 2006			

<b>U.S. PATENT DOCUMENTS</b>					
*Examiner Initials		Document Number	Date mm/dd/yy	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/JU/	A01	2003/0073083	04/17/2003	Tamayo et al.	
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<b>NON PATENT LITERATURE DOCUMENTS</b>					
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/JL/	C01	International Search Report for PCT Application No. PCT/US05/22071, dated March 16, 2006			
/JL/	C02	Written Opinion for PCT Application No. PCT/US05/22071, mailed July 18, 2006			

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<b>EXAMINER</b> /Jerry Lin/	<b>DATE CONSIDERED</b> 2/26/2011
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	